



SHEET 1 OF 1

Form PTO 1449
(Modified)U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICEATTY DOCKET NO.
287530US0X PCTSERIAL NO.
10/572,595

LIST OF REFERENCES CITED BY APPLICANT

APPLICANT
Keiichi YANOFILING DATE
October 24, 2006GROUP
2811

U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
	AA						
	AB						
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						
	AL						
	AM						
	AN						

FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION	
					YES	NO
/M.L./	AO	9-293904	11/11/1997	Japan (submitting English abstract only; reference previously filed on 03/20/2006)		X
/M.L./	AP	10-279377	10/20/1998	Japan (submitting English abstract only; reference previously filed on 03/20/2006)		X
	AQ					
	AR					
	AS					
	AT					
	AU					
	AV					

OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)

	AW				
	AX				
	AY				
	AZ				

☐ Additional References sheet(s) attached

Examiner /Meiya Li/

Date Considered 01/24/2008

*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

	Docket No.: 287530US0X PCT	Serial No.: 10/572,595
LIST OF RELATED CASES CITED BY APPLICANT UNDER 37 CFR 1.56	Inventor: Keiichi YANO	
	Filing Date: October 24, 2006	Group: 2811

LIST OF RELATED CASES

<u>Examiner Initial</u>	<u>Docket No.</u>	<u>Serial or Patent Number</u>	<u>Filing or Issue Date</u>	<u>Patent App. Publication No.</u>	<u>Inventor or Applicant</u>
/M.L./	306103US0XPCT	11/576,533	04/03/07		YANO
/M.L./	287530US0XPCT*	10/572,595	10/24/06		YANO

Examiner /Meiya Li/ Date Considered 01/24/2008

*Present Application; listed for information
NFO/ach

Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. 287530US0X PCT		SERIAL NO. New U.S. PCT Application Based on PCT/JP04/14686	
LIST OF REFERENCES CITED BY APPLICANT				APPLICANT Keiichi YANO			
				FILING DATE Herewith		GROUP 2811	
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
/M.L./	AA	5 124 234	06/23/92	WAKATA et al.			
/M.L./	AB	6 274 924	08/14/01	CAREY et al.			
	AC						
	AD						
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	AM						
	AN						
FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES NO		
/M.L./	AO	09-293904	11/11/97	JP		NO	
↓	AP	10-279377	10/20/98	JP		NO	
	AQ	1 059 667	12/13/00	EP (equivalent of US6489637 & US6548832)		NO	
	AR	10 215801	08/11/98	JP		NO	
	AS	2002 22182	01/24/02	JP		NO	
	AT						
	AD						
	AV						
OTHER REFERENCES (Including Author, Title, Date, Portment Pages, etc.)							
	AW						
	AX						
	AY						
	AZ						
					<input type="checkbox"/> Additional References sheet(s) attached		
Examiner /Meiya Li/					Date Considered 01/24/2008		
<small>*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.</small>							